

1. Scope

This specification is applies to Multilayer Ceramic Chip Capacitor (MLCC) for use in electric equipment for the voltage is ranging from 100V to 5KV.

The MLCC support for Lead-Free wave and reflow soldering, and electrical characteristic and reliability are same as before. (This product compliant with the RoHS.)

2. Parts Number Code

С	0805	Х	472	K	251	Т
(1)	(2)	(3)	(4)	(5)	(6)	(7)

(1)Product

Product Code	
С	Multilayer Ceramic Chip Capacitor
(2) Chin Cina	

(2)Chip Size		
Code	Length×Width	unit : mm(inch)
0201	0.60× 0.30	(.024× .011)
0402	1.00× 0.50	(.039× .020)
0603	1.60× 0.80	(.063× .031)
0805	2.00× 1.25	(.079× .049)
1206	3.20× 1.60	(.126× .063)
1210	3.20× 2.50	(.126× .098)
1808	4.60× 2.00	(.181× .079)
1812	4.60× 3.20	(.181× .125)
1825	4.60× 6.35	(.181× .250)
2208	5.70× 2.00	(.220× .197)
2211	5.70× 2.80	(.220× .110)
2220	5.70× 5.00	(.220× .197)
2225	5.70× 6.35	(.220× .250)

(3) Temperature Characteristics

Cod€	Γemperature	Temperature	Temperature
	haracteristi	Range	Coefficient
N	NPO	-55°℃~+125°℃	30 ppm/°C
L	SL	-30°C ~+85°C	+350~-1000ppm
X	X7R	-55℃~+125℃	± 15%
В	X5R	-55°C ~+85°C	± 15%
S	X6S	-55°C ~+105°C	± 22%
Υ	Y5V	-30°C ~+85°C	+22/-82%
Z	Z5U	+10°℃~+85°℃	+22/-56%
Е	Y5U	-30°C ~+85°C	+22/-56%

(4)Capacitance unit :pico farads(pF)

_	
Code	Nominal Capacitance (pF)
5R0	5.0
120	12.0
151	150.0
472	4,700.0
103	10,000.0
474	470,000.0
105	1,000,000.0
106	10,000,000.0

**. If there is a decimal point, it shall be expressed by an

(5) Capacitance Tolerance

Code	Tolerance	Nominal Capacitance
В	± 0.10 pF	Less Than 10 pF
С	± 0.25 pF	(Include 10 pF)
D	± 0.50 pF	
E	± 1.00 pF	
F	± 1.00 %	More Than 10 pF
G	± 2.00 %	
J	± 5.00 %	
K	± 10.0 %	
М	± 20.0 %	
Z	+80/-20 %	

(6)Rated Voltage

Code	Rated Voltage (Vdc)
101	100
201	200
251	250
501	500
631	630
102	1,000
202	2,000
252	2,500
302	3,000
502	5,000

(7)Tapping

Code	Type	
Т	Tape & Reel	
В	Bulk	

English capital letter R

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3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

Class	Characteristic	Tolera	ance	Nominal Capacitance
I	NPO / SL	Less Then 10 pF	B (± 0.10 pF)	0.5,1,1.5,2,2.5,3
			C (± 0.25 pF)	0.5,1,1.5,2,2.5,3,3.5,4,4.5,5
			D (± 0.50 pF)	5,6,7,8,9,10
			E (± 1.00 pF)	6,7,8,9,10
		More Than 10 pF	F (±1.00 %)	E-12, E-24 series
			G (±2.00 %)	
			J (± 5.00 %)	
			K (± 10.0 %)	
П	X7R/X5R/X7E	K (± 10.0 %),	M (± 20.0 %)	E-3, E-6 series
	Y5V	M (± 20.0 %), Z	Z(+80/-20 %)	E- 3 series
	Z5U			
	Y5U			

3.2 E series(standard Number)

Standard No.	Application Capacitance											
E- 3		1.0 2.2 4.7					.7					
E- 6	1.	.0	1	.5	2	.2	3	.3	4	.7	6	.8
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
E-24	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
	1.1	1.3	1.6	2.0	2.4	3.0	3.6	4.3	5.1	6.2	7.5	9.1

4. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
I	NPO	-55°C ~ +125°C	25 ℃
	SL	-25°C ~ +125°C	25 ℃
П	X7R	-55℃ ~ +125℃	25 ℃
	X5R	-55℃ ~ +85℃	25 ℃
	X6S	-55°C ~ +105°C	25 ℃
	Y5V	-30°C ~ +85°C	25 ℃
	Z5U	+10°C ~ +85°C	25 ℃
	Y5U	-30°C ~ +85°C	25 ℃
	Other	-25℃ ~ +85℃	25 ℃

5. Storage Condition

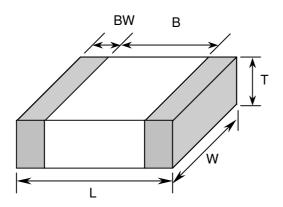
Storage Temperature : 5 to 40° C Relative Humidity : 20 to 70 % Storage Time : 6 months max.

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6. Dimensions

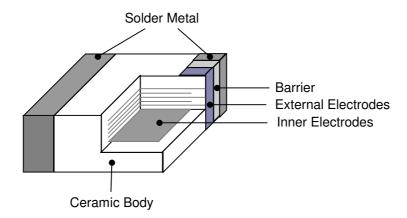
6.1 Configuration and Dimension:



Unit:mm

TYPE	L	W	T	B (min)	BW (min)
0805	2.00± 0.20	1.25± 0.20	0.85± 0.10	0.70	0.20

6.2 Termination Type :





7. Performance

				Test Condition				
No.	Item			Specification	Test Condition			
1	Visua			exterior appearance	Visual inspection			
2	Dimens	sion	See Page 3		Visual inspection			
3	3 Insulation Resistance		10,000MΩ or Product Whice	σ 500/C Ω chever Is Smaller	V≦500V, Rated Voltage V>500V, Applied 500Vdc Charge Time: 60sec. Is applied less than 50mA current.			
4	Capacitance	Class ī	Within The Sp	ecified Tolerance	Class I:			
		NPO/SL			NPO/SL			
		Class	Within The Sp	ecified Tolerance	CapacitanceFrequencyVoltageC≤100pF1MHz±10%1.0±0.2VrmsC>100pF1KHz±10%			
5	Q	Class	More Than 30	pF : Q ≧ 1000	Class Ⅱ :			
		I	30pF & Below	: Q ≥ 400 + 20C	Frequency Voltage			
		NPO/SL	(C : Capacita	ince , pF)	X7R 1KHz±10% 1.0±0.2Vrms Z5U/Y5U 1KHz±10% 1.0±0.2Vrms			
	Tan δ	Class	Char.	Maximum	Z5U/Y5U 1KHz±10% 1.0±0.2Vrms Perform a heat temperature at 150±5°C for			
		П	X7R Z5U/Y5U	2.5% 4.0%	30min. then place room temp. for 24±2hr.			
7	6 Withstanding No or Medical Notage 7 Temperature Capacitance Coefficient Class I NPO SL		No dielectric mechanical b Char. Temp. F NPO -55°C ~- SL -30°C ~- Char. Temp. F	Range Cap. Change(%) +125°C ± 30 ppm/°C -85°C +350~-1000ppm Range Cap. Change(%)	[C2-C1/C1(T2-T1)] × 100% Class II :			
		П	X7R -55°C ~- Y5U -30°C ~ Z5U +10°C ~	+85°C +22% ~-56% +85°C +22% ~-56%	T1: Standard temperature (25℃) T2: Test temperature C1:Capacitance at standard temperature(25℃) C2: Capacitance at test temperature (T2)			
8	8 Adhesive Strength of Termination		No indication of peeling shall occur on the terminal electrode.		A 5N·f (≒0.5Kg·f) pull force shall be applied for 10± 1 second. 5N·f			
9	Resistance to	Appear- ance	No mechanica	al damage shall be occur.	Bending shall be applied to the 1.0 mm with 1.0 mm/sec.			
	Flexure of Substrate		Capacitance C Char. NPO SL X7R Y5U/Z5U	Change Cap. Change ≤ ± 5.0% ≤ ± 5.0% ≤ ± 12.5% ≤ ± 30.0%	Bending Limit C. Meter 45±1mm 45±1mm			



No.	Iter	n		Spe	cific	cation			7	est Conditio	n			
10	Solderability		More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve .				Solder Temperature: 245± 5°C Dip Time: 5 ± 0.5 sec. Immersing Speed: 25±10% mm/s Solder: H63A Flux:Rosin Preheat: At 80~120 °C for 10~30sec.							
11	Resistance To Soldering Heat	Appearance Capacitance Q Class I Tan δ Class II Insulation Resistance Withstand Voltage	Class I (NPO/S	X7R Z5U/Y5L sfy the spe	J ecifie	Cap. Change Within ± 2.5% or ±0.25pFwhichever is larger of initial value Within ± 10% Within ± 20% ed initial value ed initial value ed initial value ed initial value	tr tr	Class ☐ capacitor shall be set for 48±4 hour room temperature after one hour heat treatment at 150 +0/-10°C before initial measure.			hours a			
12	Tempera ture Cycle	Appearance Capacitance Q Class I Tan δ Class II	Class I (NPO/S	X7R Z5U/Y5U sfy the spe	J ecifi	Cap. Change Within ± 2.5% or ±0.25pFwhichever is larger of initial value Within ± 7.5% Within ± 20% ed initial value ed initial value ed initial value	a A N	Capacithe ten Step 1 2 3 4 Measure Class Class Solder	mperature -0/-10 °C the state of the state	Hrs citor on P.C.	to ow 3	fiving	eat to sure. ye cycle: ime(i) 30 3 30 3 r coo	cles of
13	Humidity	Appearance Capacitance Q Class I Tan δ Class II Insulation Resistance	Char Class I (NPO/S Class II More T 30pF & Ch X7 Z5U/ 1,000M	xacteristic SL) X7R Z5U/Y5U Than 30pF Below: Q ar. 7R Y5U 1\Omega or 50/0	V ± Ia V V : Q ≥ 2	Cap. Change Vithin ± 5.0% or 0.5pF whichever is arger of initial value Vithin ± 15% Vithin ± 30% ≥ 350 275 +2.5×C Maximum 5.0% 5.0% Whichever is			it ling for					

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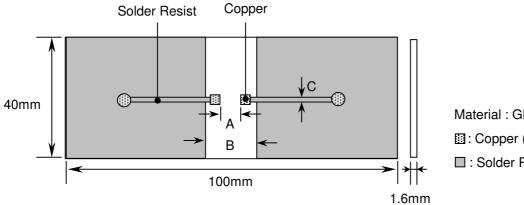
HVC-008-0807

No.	Iten	n		Spec	cifi	cation		Test Condition			
14	High	Appear-	No me	chanical da	ıma	age shall occur		ass	ū		
	•	ance						ollowing table) is app			
	Load	Capacit-	Characteristic			Cap. Change	maximum operation temperature $\pm 3\%$ then				
	(Life Test)	ance	Class I			Within ±3.0% or	sh	all be set for 48±4 ho	urs at room temperature		
			(NPO/	SL)		± 0.3pFwhichever	an	d the initial measurer	ment shall be		
						is larger	СО	nducted.			
			Class	X7R		Within ± 15%	Αp	plied Voltage:			
			П	Z5U/Y5U		Within ± 30%	J ',				
		Q	More 7	Γhan 30pF :	Q	≧ 350		Rated Voltage	Applied Voltage		
		Class I			≧ 2	275 + 2.5× C		V≤250Vdc	150%Rated Voltage		
		Tan δ		nar.		maximum		Less Than 1KVdc			
		Class ∏		7R		5.0%		More Than	120%Rated Voltage		
				/Y5U		5.0%		1KVdc(include 1KV)	100%Rated Voltage		
						whichever is					
		Resistance	smalle	r.		(C in Farad)	1010/100V conscitance more than 1 0uF				
							1210/100V capacitance more than 1.0uF applied voltage of 120% rated voltage				
								mperature : max. ope			
								st Time : 1000 +12/-0			
								urrent Applied: 50 mA			
									erature after cooling for		
							Cla	ass I: 24 ± 2 Hours			
							Cla	ass II : 48 ± 4 Hours			
15	Vibration	Appear-	No me	chanical da	ıma	age shall occur			n P.C. Board shown in		
		ance					F	ig 2. before testing.			
		Capacit-		aracteristic		Cap. Change					
		ance	Class			Within ± 2.5% or			vith amplitude of 1.5mm		
			(NPO/	SL)		± 0.25pFwhichever			uencies from 10Hz to		
						is larger	5	5Hz and back to 10H	iz in about 1 min.		
			Class	X7R		Within ± 7.5%	_				
			П	Z5U/Y5U		Within ± 20%		•	each in 3perpendicular		
		Q Class I	To sati	sfy the spe	cifi	ed initial value	directions.				
		Tan δ	To sati	sty the sne	cifi	ed initial value	-				
		Class II	10 5411	satisfy the specified initial value		oa miliar valuo					
		Insulation	To sati	sfy the spe	cifi	ed initial value	1				
		Resistance									

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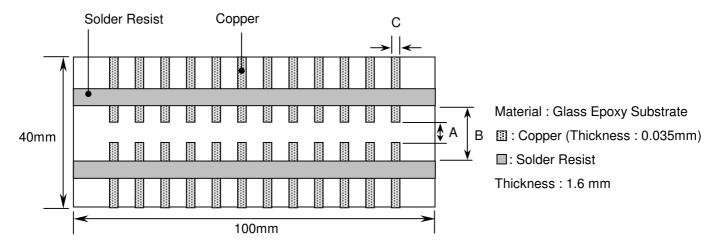
Fig.1 P.C. Board for Bending Strength Test



Material: Glass Epoxy Substrate ■: Copper (Thickness : 0.035mm)

☐ : Solder Resist

Fig.2 **Test Substrate**



			Unit:mm
Туре	Α	В	С
0201	0.2	0.9	0.4
0402	0.5	1.5	0.6
0603	1.0	3.0	1.0
0805	1.2	4.0	1.6
1206	2.2	5.0	2.0
1210	2.2	5.0	2.9
1808	3.5	7.0	2.5
1812	3.5	7.0	3.7
2208	4.5	8.0	2.5
2211	4.5	8.0	3.0
2220	4.5	8.0	5.6
1825	3.5	7.0	6.9
2225	4.5	8.0	7.0

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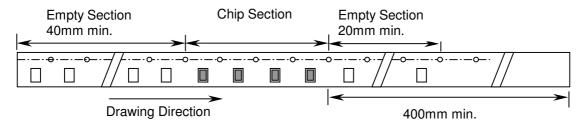


8. Packing

8.1 Bulk Packing

According to customer request.

8.2 Chip Capacitors Tape Packing



8.3 Material And Quantity

Tape	0201	0402	0603/	0805
Material	T≦0.33mm	T≦0.55mm	T≦0.90mm	T>0.90mm
Paper	15,000 pcs/Reel	10,000 pcs/Reel	4,000 pcs/Reel	NA
Plastic	NA	NA	NA	3,000 pcs/Reel

Tape		1206	1210/1808		
Material	T≦0.90mm	$0.90 \text{mm} < T \le 1.25 \text{mm}$	T>1.25mm	T≦1.25mm	T>1.25mm
Paper	4,000 pcs/Reel	NA	NA	NA	NA
Plastic	NA	3,000 pcs/Reel	2,000 pcs/Reel	3000 pcs/Reel	2000 pcs/Reel

Tape	1812/1825	/2211/2220	22	25	2208
Material	T≦2.20mm	T>2.20mm	T≦2.20mm	T>2.20mm	T≦2.20mm
Paper	NA	NA	NA	NA	NA
Plastic	1000 pcs/Reel	700 pcs/Reel	1000 pcs/Reel	400 pcs/Reel	1000 pcs/Reel

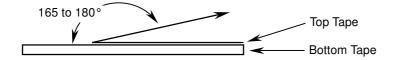
NA: Not Available

8.4 Cover Tape Reel Off Force

8.4.1 Peel-Off Force

 $5 g \cdot f \leq Peel-Off Force \leq 70 g \cdot f$

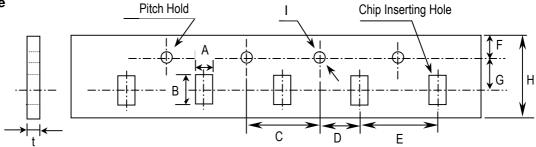
8.4.2 Measure Method



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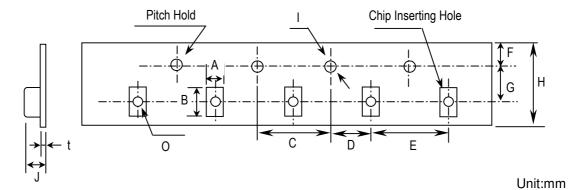


Unit:mm

TYPE	Α	В	С	D	Е
0201	0.37± 0.1	0.67± 0.1	4.00± 0.1	2.00± 0.05	2.00± 0.1
0402	0.61± 0.1	1.20± 0.1			
0603	1.10± 0.2	1.90± 0.2			4.00± 0.1
0805	1.50± 0.2	2.30± 0.2			
1206	1.90± 0.2	3.50± 0.2			
1210	2.90± 0.2	3.60± 0.2			

TYPE	F	G	Н		t
0201	1.75± 0.10	3.50± 0.05	8.0± 0.30	φ 1.50 +0.10/-0	1.10 max.
0402					
0603					
0805					
1206					
1210					

8.6 Plastic Tape



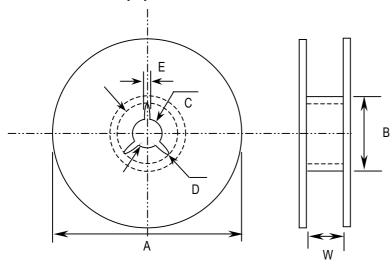
Type	Α	В	С	D	E	F
0805	1.5±0.2	2.3±0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
1206	1.9±0.2	3.5±0.2				
1210	2.9±0.2	3.6±0.2				
1808	2.5±0.2	4.9±0.2				
1812	3.6±0.2	4.9±0.2			8.0± 0.1	
1825	6.9±0.2	4.9±0.2				
2208	2.5±0.2	6.1±0.2				
2211	3.2±0.2	6.1±0.2				
2220	5.4±0.2	6.1±0.2				
2225	6.9±0.2	6.1±0.2				



Туре	G	Н		J	t	0
0805	3.5± 0.05	8.0± 0.3	φ 1.5+0.1/-0	3.0 max.	0.3 max.	0.15 min.
1206						
1210						
1808	5.5± 0.05	12.0 ± 0.3		4.0 max.		
1812						
1825						
2208						
2211						
2220						
2225						

8.7 Reel Dimensions

Reel Material : Polystyrene



Unit:mm

Туре	А	В	С	D	E	W
0201	φ 382 max	arphi 50 min	φ 13± 0.5	φ 21± 0.8	2.0±0.5	10± 0.15
0402						
0603						
0805						
1206						
1210						
1808	φ 178±0.2	φ 60±0.2				13±0.3
1812						
1825						
2208						
2211						
2220						
2225						



Precautionary Notes:

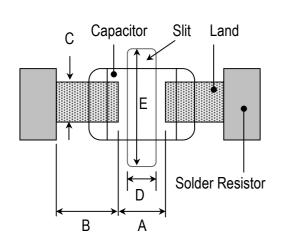
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40 °C and 70%RH. We recommend that the capacitors be used within 6 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering .

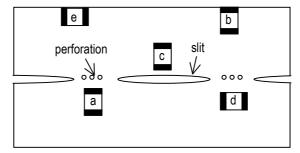


EIA Code	Chip (mm)		Land (mm)				
	L	W	Α	В	С	D	Е
0201	0.60	0.30	0.2~0.3	0.2~0.4	0.2~0.4		
0402	1.00	0.50	0.3~0.5	0.3~0.5	0.4~0.6		1
0603	1.60	0.80	0.4~0.6	0.6~0.7	0.6~0.8		1
0805	2.00	1.25	0.7~0.9	0.6~0.8	0.8~1.1		1
1206	3.20	1.60	2.2~2.4	0.8~0.9	1.0~1.4	1.0~2.0	3.2~3.7
1210	3.20	2.50	2.2~2.4	1.0~1.2	1.8~2.3	1.0~2.0	4.1~4.6
1808	4.60	2.00	2.8~3.4	1.8~2.0	1.5~1.8	1.0~2.8	3.6~4.1
1812	4.60	3.20	2.8~3.4	1.8~2.0	2.3~3.0	1.0~2.8	4.8~5.3
1825	4.60	6.35	2.8~3.4	1.8~2.0	5.1~5.8	1.0~4.0	7.1~8.3
2208	5.70	2.00	4.0~4.6	2.0~2.2	1.5~1.8	1.0~4.0	3.6~4.1
2211	5.70	2.80	4.0~4.6	2.0~2.2	2.0~2.6	1.0~4.0	4.4~4.9
2220	5.70	5.00	4.0~4.6	2.0~2.2	3.5~4.8	1.0~4.0	6.6~7.1
2225	5.70	6.35	4.0~4.6	2.0~2.2	5.1~5.8	1.0~4.0	7.1~8.3

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended. Susceptibility to stress is in the order of: a>b>c and d>e



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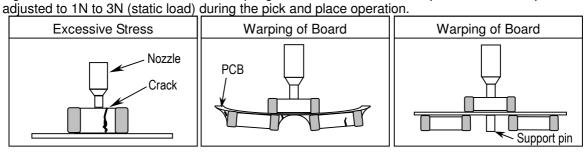


2.3 Layout Recommendation

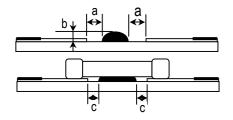
Example	Use of Common Solder Land	Solder With Chassis	Use of Common Solder Land With Other SMD
Need to Avoid	Chip Solder Adhesive PCB Solder Land	Chassis Excessive Solder a	Solder Land
Recommendation	Chip Solder Resist Adhesive PCB Solder Land	Solder Resist $\alpha > \beta$	

3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically



3.2 Amount of Adhesive



 Example : 0805 & 1206

 a
 0.2mm min.

 b
 70 ~ 100 μm

 C
 Do not touch the solder land

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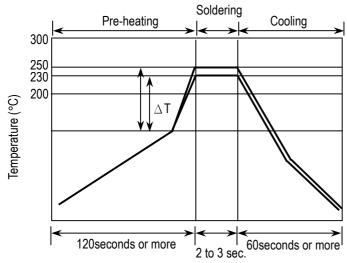


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to $250\,^{\circ}$ C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



Soldering Method	Change in Temp.(°C)
1206 and Under	$\Delta T \le 100 \sim 130 \text{ max}.$

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
 - a. Flux flows to easily
 - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

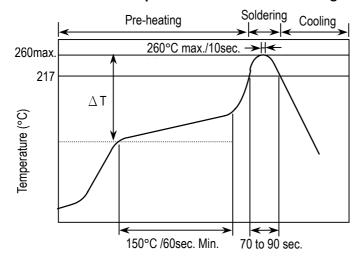
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) between the solvent and the chips must be less than 100 °C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed $3\,\text{C/Sec}$.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



The cycles of soldering: Twice (max.)

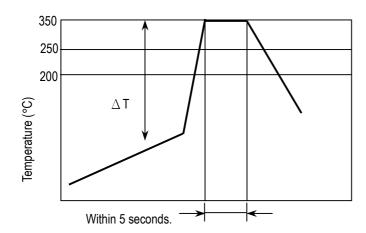
Soldering Method	Change in Temp.(°C)	
1206 and Under	∆T ≦ 190 °C	
1210 and Over	∆T ≦ 130 °C	

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4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



Soldering Method	Change in Temp.(°C)
1206 and Under	Δ T \leq 190 $^{\circ}$ C
1210 and Over	∆ T ≦ 130 °C

How to Solder Repair by Solder Iron

1) Selection of the soldering iron tip

The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.

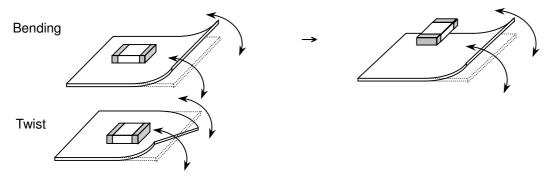
- 2) recommended solder iron condition
 - a.) Preheat the substrate to $(60\,^{\circ}\text{C})$ to $120\,^{\circ}\text{C}$ to $120\,^{\circ}\text{C}$ on a hot plate. Note that due to the heat loss, the actual setting of the hot plate may have to be higher. (For example $100\,^{\circ}\text{C}$ to $150\,^{\circ}\text{C}$)
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350 ℃., and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
 - f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
 - g.) After soldering operation, let the products cool down gradually in the room temperature.

5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.

Higher potential of crack

Lower potential of crack



5.2 There is a potential of crack if board is warped due to excessive load by check pin



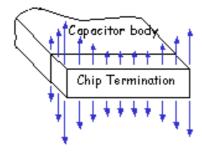
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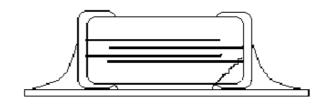


- 5.3 Mechanical stress due to warping and torsion.
 - (a) Crack occurrence ratio will be increased by manual separation.
 - (b) Crack occurrence ratio will be increased by tensile force, rather than compressive force.



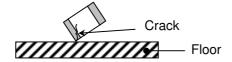
Capacitor Stress Analysis



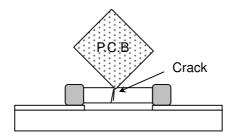


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40 °C and under humidity of 20 to 75% RH. The shelf life of capacitors is 6 months.

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